

Quarterly Reliability Monitoring Results

Quarters: Q1/2021 to Q4/2021

Based on structural similarity

Supplier Nexperia B.V. Name of Laboratory Assembly reliability labs		User Part Number PCMF1HDMI14S Part Description												
									NXP ICN8 Protection INDI					
									WLCSP package					
		Test		Test Conditions	Duration	# Lots	# Quantity	# Rejects						
			TEST Pre- and Post-Stress											
# 1	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below								
		MIL-STD-750-1 M1038 Method A Tj = Tjmax, Vr = 100% of max. datasheet												
# 5	Bias	reverse voltage	1000 hours	43	3440	0								
# 7	TC Temperature Cycling	JESD22-A104 -40 °C to 125°C	1000 cycles	16	1280	0								
# 8	AC Autoclave	JESD22-A102 Tamb = 121 °C, RH = 100 % Pressure = 205 kPa (29.7 psia)	96 hours	n.a.	n.a.	n.a.								
# 9	HAST Highly Accelerated Stress Test	JESD22-A110 Tamb = 130 °C, RH = 85%, VR = 80 % of rated reverse voltage $^{[1]}$	1000 hours	16	1280	0								
# 10	IOL Intermittent Operating Life	MIL-STD-750 Method 1037 ton = toff, devices powered to insure $\Delta Tj = 100$ °C for 15000 cycles	1000 hours	n.a.	n.a.	n.a.								
# 20	RSH Resistance to Solder Heat	JESD22-A111 260 °C ± 5 °C	10 s	n.a.	n.a.	n.a.								
# 21	SD Solderability	J-STD-002	10 3	n.a.	n.a.	n.a.								

^[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test # 5) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Wafer Fab	Technology	Quantity	Rejects	Failure Rate (FIT)	MTTF (hrs)
NXP ICN8	Protection INDI	3440	0	1.2	8.10E+08

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